Search Notes



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Applicant(s)/Patent Under Reexamination

HONGO ET AL.

Examiner

Art Unit

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Chun-Cheng Wang

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SEARCHED							
Class		Subclass	Date	Examiner			
516	97		11/11/2008	/CCW/			

SEARCH NOTES				
Search Notes	Date	Examiner		
See EAST search history report	11/11/2008	/CCW/		
Inventor search	11/11/2008	/CCW/		
Japan patant search	11/11/2008	/CCW/		
Internet search about membrane integrity test and membrane	11/11/2008	/CCW/		

INTERFERENCE SEARCH					
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